

Form PTO-1449 (REV. 8-83)	US Dept. of Commerce PATENT & TRADEMARK OFFICE	ATTY DOCKET NO. 108572	APPLICATION NO. 09762,589			
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT(S) Basil LUI				
		FILING DATE March 30, 2001	GROUP 2858			
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)						
EG	1	Lui et al., "A new generation -recombination model for device simulation including the poole-frenkel effect and phonon-assisted tunneling", Solid-State Electronics, Vol. 41, No. 4, pp 575-583, 1997				
EG	2	Pelaz et al., "The Poole-Frenkel Effect in 6H-SiC Diode Characteristics", IEEE Transactions on Electron Devices, Vol. 41, No. 4, April 1994, pp. 587-591				
EG	3	Reisch, "Tunneling-Induced Leakage Currents in pn Junctions", Archiv fur Elektronik und Uebertragungstechnik, Vol. 44, No. 5, Sept.-Oct. 1990, pp. 368-382				
EXAMINER ED GARCIA-OTERO				DATE CONSIDERED 7/6/04		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

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